



Introduction to Advanced Pattern Recognition

Marco Loog

ASCI A1 : Advanced Pattern Recognition



Supervised Learning

- Aims to find solutions to difficult decision, classification, and prediction problems
- Automation often, possibly implicit, an issue
 - Have computers and robots do task that are dangerous, tedious, boring, etc.
- Part of the point : Humans often severely biased in judgment, very inaccurate

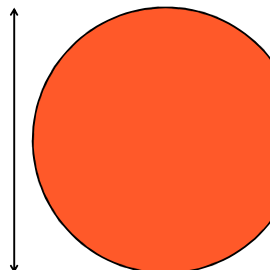


Comparing and ...



Supervised Learning = Not Modeling

- Fruits orange, reddish-green to yellowish-green, round, 4-12 cm, consist of a leathery peel 6 mm thick, tightly adherent, protecting the juicy inner pulp, which is divided into segments that may not contain seeds, depending on the cultivar...



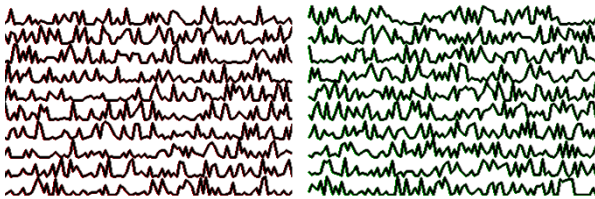
Orange Modeling

- Difficult, hassle, overly ambitious, inaccurate,...
- Captures typicalities



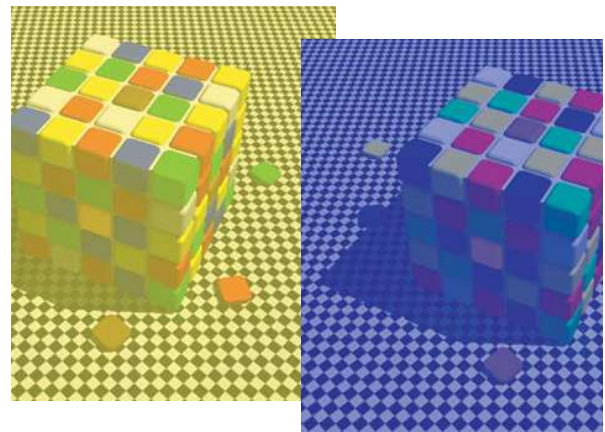
Supervised Learning

- ...is learning by example
- Given input and associated output, determine input-output mapping
- Mapping should be able to **generalize** to new and previously unseen examples



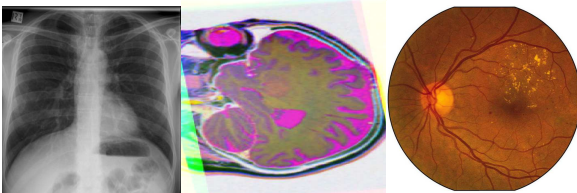
Some Remarks

- In the end, one never relies solely on extremes of pure modeling or pure model-free learning
- Learning does use models, though they are weak and nonspecific
- Part of the point : Humans often severely biased in judgment, very inaccurate
 - Cannot even trust your own eyes

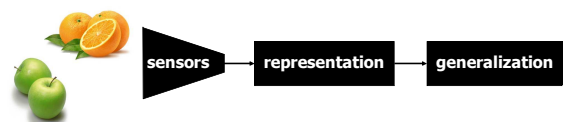


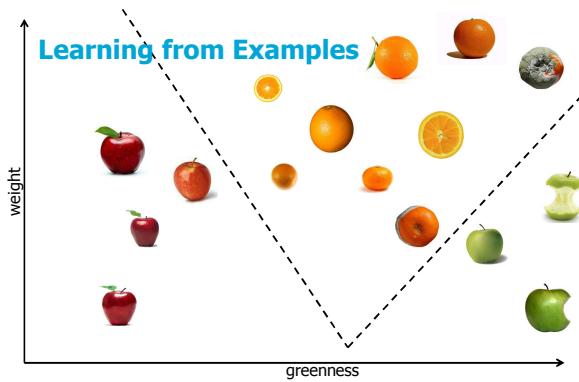
Some Problem Types

- Classification, segmentation, detection



Basic Pattern Recognition Machine





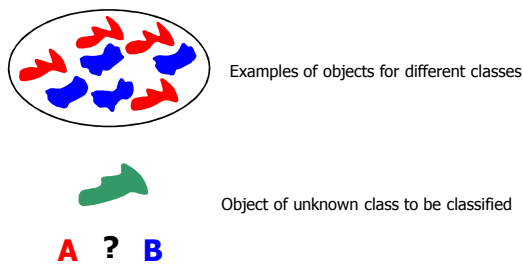
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On Features

- How do we get to features?
- Features are based on knowledge
 - Good knowledge \Rightarrow good features \Rightarrow [almost] separable groups
 - Lack of knowledge \Rightarrow [too many] bad features \Rightarrow hardly separable groups
 - Many features \approx lack of knowledge

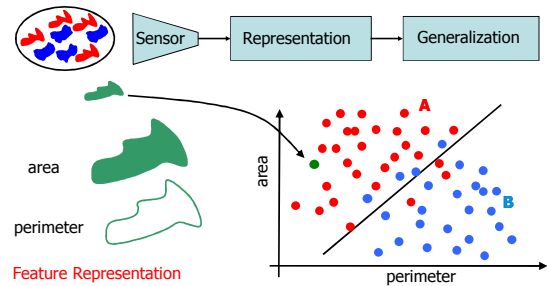
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Pattern Recognition



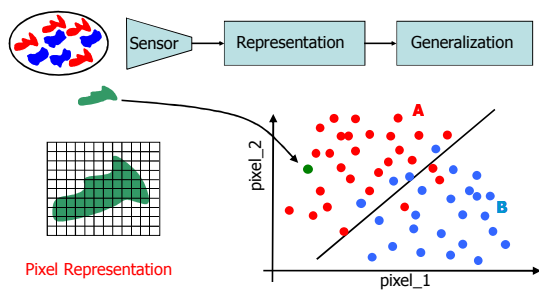
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Pattern Recognition System



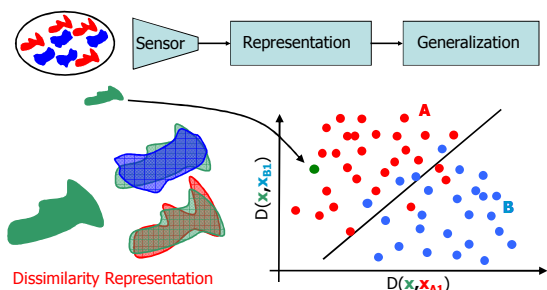
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Pattern Recognition System



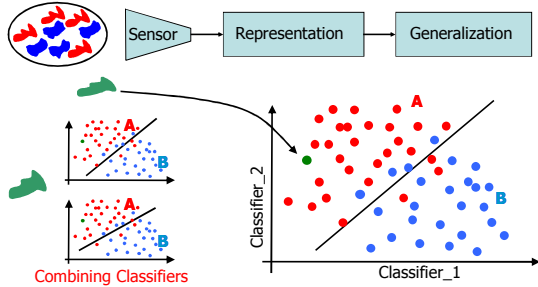
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Pattern Recognition System



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Pattern Recognition System



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Features Reduce!

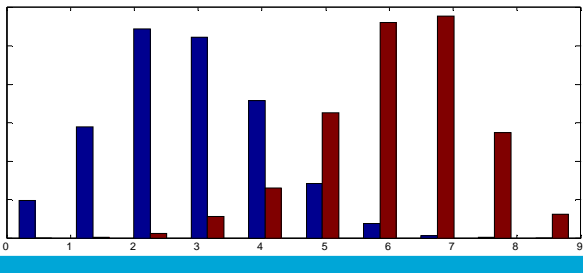
- Classes in feature space overlap
- Features only tell you part of the story



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Probabilistic Generalization

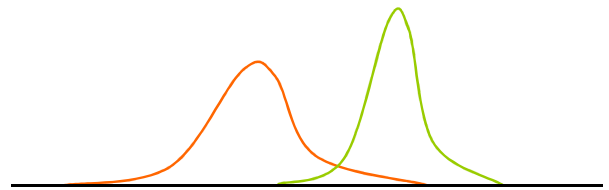
- Probabilities good for overlapping classes



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Probabilistic Generalization

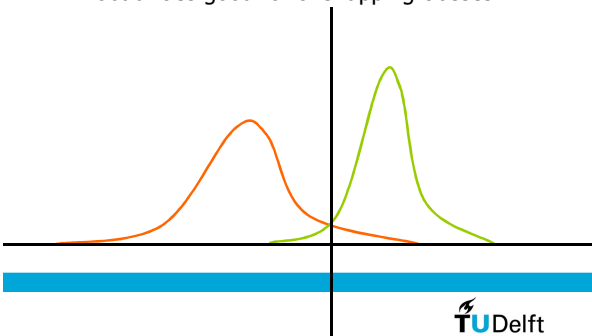
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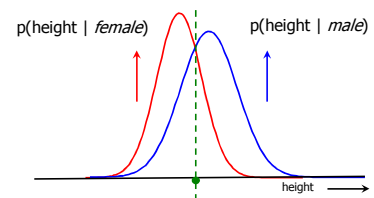
Probabilistic Generalization

- Probabilities good for overlapping classes



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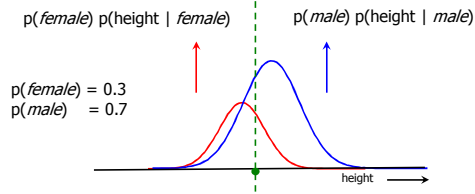
So How to?



Guess what is the gender of somebody with certain height...

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Decisions Based on Densities



Guess what is the gender of somebody with certain height...



Bayes Decision Rule

$$p(\text{female} | \text{height}) > p(\text{male} | \text{height}) \rightarrow \text{female else male}$$

Bayes :

$$\frac{p(\text{height} | \text{female}) p(\text{female})}{p(\text{height})} > \frac{p(\text{height} | \text{male}) p(\text{male})}{p(\text{height})}$$

$$p(\text{height} | \text{female}) p(\text{female}) > p(\text{height} | \text{male}) p(\text{male}) \rightarrow \text{female else male}$$

pdf estimated from training set

class prior probabilities known, guessed or estimated



Bayes Decision Rule

$$p(A|x) > p(B|x) \rightarrow A \text{ else } B$$

$$\frac{p(x|A) p(A)}{p(x)} > \frac{p(x|B) p(B)}{p(x)} \rightarrow A \text{ else } B$$

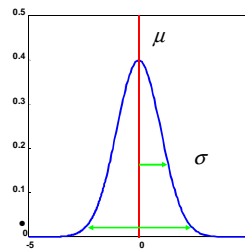
$$p(x|A) p(A) > p(x|B) p(B) \rightarrow A \text{ else } B$$

2-class problems: $S(x) = p(x|A) p(A) - p(x|B) p(B) > 0 \rightarrow A \text{ else } B$

n-class problems: $\text{Class}(x) = \text{argmax}_{\omega} (p(x|\omega) p(\omega))$



Gaussian Distribution



• Normal distribution = Gaussian distribution

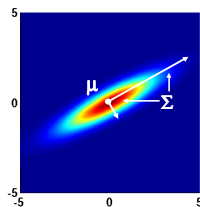
• Standard normal distribution:
 $\mu = 0, \sigma^2 = 1$

• 95% of data between $[\mu - 2\sigma, \mu + 2\sigma]$ [in 1D!]

$$p(x) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp\left(-\frac{1}{2} \frac{(x-\mu)^2}{\sigma^2}\right)$$



Multivariate Gaussians



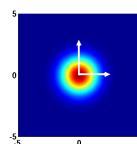
$$\Sigma = \begin{bmatrix} 3 & 1\frac{1}{2} \\ 1\frac{1}{2} & 2 \end{bmatrix}$$

• k - dimensional density :

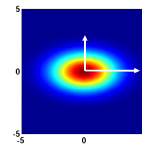
$$p(\mathbf{x}) = \frac{1}{\sqrt{(2\pi)^k \det(\Sigma)}} \exp\left(-\frac{1}{2} (\mathbf{x}-\boldsymbol{\mu})^T \Sigma^{-1} (\mathbf{x}-\boldsymbol{\mu})\right)$$



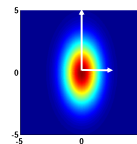
Multivariate Gaussians



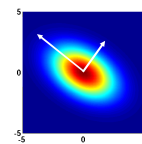
$$\Sigma = \begin{bmatrix} 1 & 0 \\ 0 & 1 \end{bmatrix}$$



$$\Sigma = \begin{bmatrix} 3 & 0 \\ 0 & 1 \end{bmatrix}$$



$$\Sigma = \begin{bmatrix} 1 & 0 \\ 0 & 3 \end{bmatrix}$$

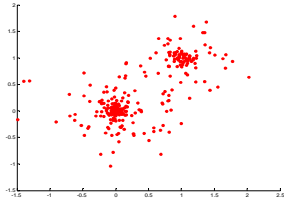


$$\Sigma = \begin{bmatrix} 3 & -1 \\ -1 & 1 \end{bmatrix}$$



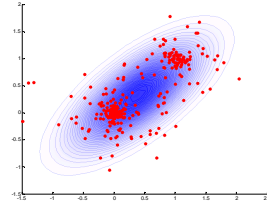
Parametric Estimation

- Assume Gaussian model
- Estimate mean and covariance from data



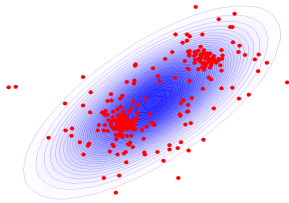
Parametric Estimation

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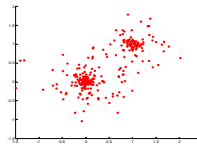
Parametric Drawback

- Poor model fit resulting in invalid conclusions
- Model not flexible enough



Mixture Modelling

- Often used parametric model
- Comes closer to nonparametric formulations
- Basic idea is to model complex pdf as weighted sum of simple pdfs



$$p(x) = \sum_{i=1}^N P_i p(x|\theta_i)$$

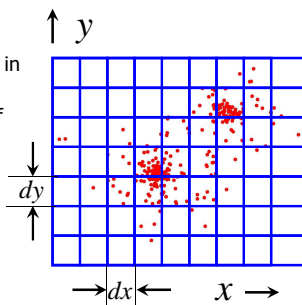


Nonparametric Estimation

Histogram method

1. Divide feature space in N^2 bins
2. Count the number of objects in each bin
3. Normalize :

$$\hat{p}(x) = \frac{n_{ij}}{\sum_{i,j=1}^N n_{ij} dx dy}$$



Parzen Density Estimation

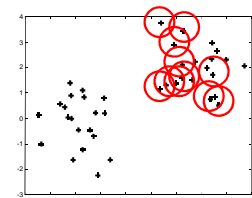
- Fix volume of bin, vary positions of bins, add contribution of each bin
- Define 'bin'-shape [kernel] :

$$K(\mathbf{r}) > 0$$

$$\int K(\mathbf{r}) d\mathbf{r} = 1$$

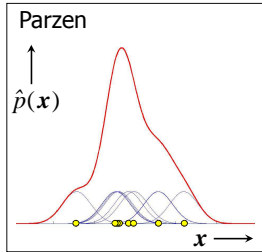
- For test object z sum all bins

$$p(z) = \frac{1}{hn} \sum_i K\left(\frac{z-x_i}{h}\right)$$



Parzen Density Estimation

- With Gaussian kernel : $K(x) = \frac{1}{h\sqrt{2\pi}} \exp\left(-\frac{x^2}{2h^2}\right)$



Conclusions for This First Hour

- Learning can be considered the opposite of modeling
- Learning from examples is based on features
- The class overlap causes need for probabilities
- Correct probability densities \Rightarrow optimal classification
- Typically, need to resort to some form of estimation